Philips Components-Signetics

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Status	Product Specification				
Memory Produ	icts				

82S147 / 82S147A 4K-bit TTL bipolar PROM

DESCRIPTION

The 82S147 and 82S147A are field-programmable, which means that custom patterns are immediately available by following the Signetics Generic I fusing procedure. The standard devices are supplied with all outputs at locical Low. Outputs are programmed to a logic High level at any specified address by fusing the Ni-Cr link matrix.

The 82S147 and 82S147A include on-chip decoding and one Chip Enable input for ease of memory expansion, and feature 3-State outputs for optimization of word expansion in bused organizations.

Ordering information can be found on the following page.

The 82S147 and 82S147A devices are also processed to military requirements for operation over the military temperature range. For specifications and ordering information consult the Signetics Military Data Handbook.

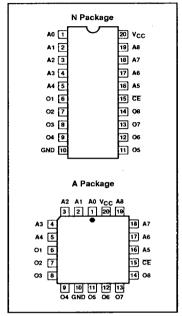
FEATURES

- Address access time:
 - N82S147: 60ns max
 - N82S147A: 45ns max
- Power dissipation: 625mW/bit typ
- Input loading: -100µA max
- One Chip Enable input
- On-chip address decoding
- · No separate fusing pins
- Fully TTL compatible
- Outputs: 3-State
- Unprogrammed outputs are Low level

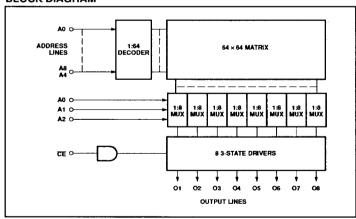
APPLICATIONS

- Prototyping/volume production
- Sequential controllers
- Microprogramming
- Hardwired algorithms
- Control store
- Random logic
- Code conversion

PIN CONFIGURATIONS



BLOCK DIAGRAM



4K-bit TTL bipolar PROM (512 \times 8)

82S147 / 82S147A

ORDERING INFORMATION

DESCRIPTION	ORDER CODE				
20-Pin Plastic Dual-In-Line 300mil-wide	N82S147 N, N82S147A N				
20-Pin Plastic Leaded Chip Carrier 350mil-square	N82S147 A, N82S147A A				

ABSOLUTE MAXIMUM RATINGS

SYMBOL	PARAMETER	RATING	UNIT	
V _{CC}	Supply voltage	+7.0	V _{DC}	
V _{IN}	Input voltage	+5.5	V _{DC}	
Vo	Output voltage Off-State	+5.5	V _{DC}	
Tamb	Operating temperature range	0 to +75	°C	
T _{stg}	Storage temperature range	-65 to +150	°C	

DC ELECTRICAL CHARACTERISTICS

 $0^{\circ}\text{C} \le \text{T}_{amb} \le +75^{\circ}\text{C}, 4.75\text{V} \le \text{V}_{CC} \le 5.25\text{V}$

				LIMITS			
SYMBOL	PARAMETER	TEST CONDITIONS ^{1,2}	Min	Typ ³	Max	UNIT	
Input volt	age						
V _{IL}	Low				0.8	٧	
V_{IH}	High		2.0			V	
V_{IC}	Clamp	I _{IN} = -12mA		-0.8	-1.2	V	
Output vo	ltage			•			
		CE = Low					
VoL	Low	$I_{OUT} = 9.6mA$			0.45	V	
V _{OH}	High	$I_{OUT} = -2mA$	2.4			V	
Input curi	rent		•				
I _{IL}	Low	V _{IN} = 0.45V			-100	μА	
I _{IH}	High	$V_{IN} = 5.5V$			40	μΑ	
Output cu	irrent						
loz	Hi-Z state	CE = High, V _{OUT} = 5.5V			40	μΑ	
	1	\overline{CE} = High, V_{OUT} = 0.5V		1	-40	μΑ	
los	Short circuit ⁴	CE = Low, V _{OUT} = 0V	-15	1	-70	mA	
Supply cu	urrent ⁵						
lcc		V _{CC} ≈ 5.25V		125	155	mA	
Capacitai	nce						
		CE = High, V _{CC} = 5.0V					
CIN	Input	$V_{1N} = 2.0V$		5		p₽	
COUT	Output	$V_{OUT} = 2.0V$		8		pF	

NOTES:

- 1. All voltages with respect to network ground.
- 2. Positive current is defined as into the terminal referenced.
- 3. Typical values are at $V_{CC} = 5V$, $T_{amb} = +25^{\circ}C$.
- 4. Duration of the short circuit should not exceed 1 second.
- 5. Measured with all inputs grounded and all outputs open.

4K-bit TTL bipolar PROM (512 × 8)

82S147 / 82S147A

AC ELECTRICAL CHARACTERISTICS

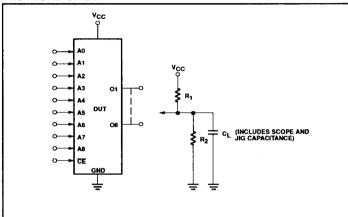
 $R_1 = 270\Omega$, $R_2 = 600\Omega$, $C_L = 30 pF$, $0^{\circ}C \le T_{amb} \le +75^{\circ}C$, $4.75V \le V_{CC} \le 5.25V$

SYMBOL	PARAMETER	то	FROM	N82S147		N82S147A				
				Min	Typ1	Max	Min	Typ1	Max	UNIT
Access time	e ²									
t _{AA}		Output	Address	T	45	60		40	45	ns
tce		Output	Chip Enable		20	35		20	30	ns
Disable tim	e ³									
t _{CD}	-	Output	Chip Disable		20	35		20	30	ns

NOTES:

- Typical values are at V_{CC} = 5V, T_{amb} = +25°C.
 Tested at an address cycle time of 1μs.
 Measured at a delta of 0.5V from Logic Level with R₁ = 750Ω, R₂ = 750Ω, C_L = 5pF.

TEST LOAD CIRCUIT



VOLTAGE WAVEFORMS

